Search Notes

Application/Control No.	Applicant(s) Reexaminat

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Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination
HAJIMIRI ET AL.
Art Unit

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SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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